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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/044,287	CHALON, DENIS	
Examiner	Art Unit	
Liang-che Alex Wang	2155	

SEARCHED			
Class	Subclass	Date	Examiner
709	206	5/17/2005	LW

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Consulted with Patrice Winder	5/17/2005	LW
Backed search	5/17/2005	LW
Updated EAST Search: USPAT, EPO, JPO, DERWENT, IBMTDB	5/17/2005	LW
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